Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/485,352	DUPRE, MICHAEL	
Examiner	Art Unit	
Ellen C. Tran	2134	

SEARCHED			
Class	Subclass	Date	Examiner
380	23	6/15/2005	ECT
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARC		·)
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH, NPL	6/15/2005	ECT
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